

2N4416/2N4416A/SST4416

N-Channel JFETs

Product Summary

Part Number	V _{GS(off)} (V)	V _{(BR)GSS} Min (V)	g _{fs} Min (mS)	I _{DSS} Min (mA)
2N4416	-≤6	-30	4.5	5
2N4416A	-2.5 to -6	-35	4.5	5
SST4416	-≤6	-30	4.5	5

Features

- Excellent High-Frequency Gain: 2N4416/A, Gps 13 dB (typ) @ 400 MHz
- Very Low Noise: 3 dB (typ) @ 400 MHz
- Very Low Distortion
- High AC/DC Switch Off-Isolation

Benefits

- Wideband High Gain
- Very High System Sensitivity
- High Quality of Amplification
- High-Speed Switching Capability
- High Low-Level Signal Amplification

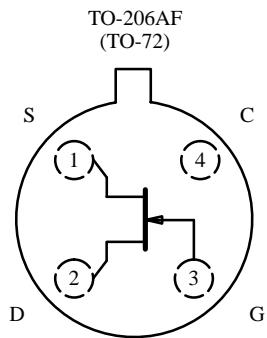
Applications

- High-Frequency Amplifier/Mixer
- Oscillator
- Sample-and-Hold
- Very Low Capacitance Switches

Description

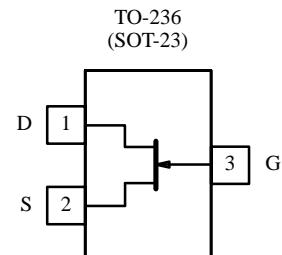
The 2N4416/2N4416A/SST4416 n-channel JFETs are designed to provide high-performance amplification at high frequencies.

The TO-206AF (TO-72) hermetically-sealed package is available with full military processing (see Military Information.) The TO-236 (SOT-23) package provides a low-cost option and is available with tape-and-reel options (see Packaging Information). For similar products in the TO-226AA (TO-92) package, see the J304/305 data sheet.



Top View

2N4416
2N4416A



Top View

SST4416 (H1)*

*Marking Code for TO-236

Updates to this data sheet may be obtained via facsimile by calling Siliconix FaxBack, 1-408-970-5600. Please request FaxBack document #70242. Applications information may also be obtained via FaxBack, request document #70597.

2N4416/2N4416A/SST4416

Absolute Maximum Ratings

Gate-Drain, Gate-Source Voltage :		Operating Junction Temperature	-55 to 150 °C
	(2N/SST4416)	-30 V	
	(2N4416A)	-35 V	
Gate Current		10 mA	
Lead Temperature		300 °C	
Storage Temperature :	(2N Prefix)	-65 to 200 °C	
	(SST Prefix)	-65 to 150°C	

Notes

- a. Derate 2.4 mW/°C above 25°C
- b. Derate 2.8 mW/°C above 25°C

Specifications^a

Parameter	Symbol	Test Conditions	Typ ^b	Limits						Unit
				2N4416		2N4416A		SST4416		
Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	
Static										
Gate-Source Breakdown Voltage	V _{(BR)GSS}	I _G = -1 μA , V _{DS} = 0 V	-36	-30		-35		-30		V
Gate-Source Cutoff Voltage	V _{GS(off)}	V _{DS} = 15 V, I _D = 1 nA	-3		-6	-2.5	-6		-6	
Saturation Drain Current ^c	I _{DSS}	V _{DS} = 15 V, V _{GS} = 0 V	10	5	15	5	15	5	15	mA
Gate Reverse Current	I _{GSS}	V _{GS} = -20 V, V _{DS} = 0 V (2N)	-2		-100		-100			pA
		T _A = 150°C	-4		-100		-100			nA
		V _{GS} = -15 V, V _{DS} = 0 V (SST)	-0.002						-1	
Gate Operating Current	I _G	V _{DG} = 10 V, I _D = 1 mA	-20							pA
	I _{D(off)}	V _{DS} = 10 V, V _{GS} = -6 V	2							
Drain-Source On-Resistance ^d	r _{DS(on)}	V _{GS} = 0 V, I _D = 1 mA	150							Ω
Gate-Source Forward Voltaged	V _{GS(F)}	I _G = 1 mA , V _{DS} = 0 V	0.7							V
Dynamic										
Common-Source Forward Transconductance ^c	g _{fs}	V _{DS} = 15 V, V _{GS} = 0 V f = 1 kHz	6	4.5	7.5	4.5	7.5	4.5	7.5	mS
Common-Source Output Conductance ^c	g _{os}		15		50		50		50	μS
Common-Source Input Capacitance	C _{iss}	V _{DS} = 15 V, V _{GS} = 0 V f = 1 MHz	2.2		4		4			pF
Common-Source Reverse Transfer Capacitance	C _{rss}		0.7		0.8		0.8			
Common-Source Output Capacitance	C _{oss}		1		2		2			
Equivalent Input Noise Voltage ^c	̄e _n	V _{DS} = 10 V, V _{GS} = 0 V f = 1 kHz	6							nV/ √Hz

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High-Frequency Specifications^{a, b} for 2N4416 and 2N4416A

Parameter	Symbol	Test Conditions	Limits				Unit	
			100 MHz		400 MHz			
			Min	Max	Min	Max		
Common Source Input Conductance	g_{iss}	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}$		100		1,000	μs	
Common Source Input Susceptance	b_{iss}			2,500		10,000		
Common Source Output Conductance	g_{oss}			75		100		
Common Source Output Susceptance	b_{oss}			1,000		4,000		
Common Source Forward Transconductance	g_{fs}				4,000		dB	
Common-Source Power Gain	G_{ps}	$V_{DS} = 15 \text{ V}, I_D = 5 \text{ mA}$	18		10			
Noise Figure	NF		$R_G = 1 \text{ k}\Omega$		2	4		

Notes

a. $T_A = 25^\circ\text{C}$ unless otherwise noted.

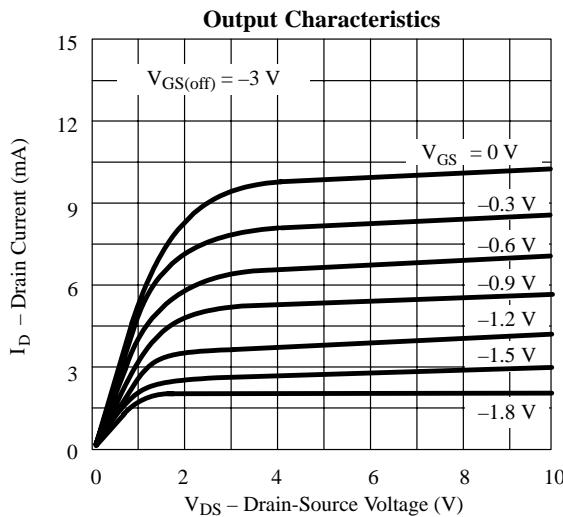
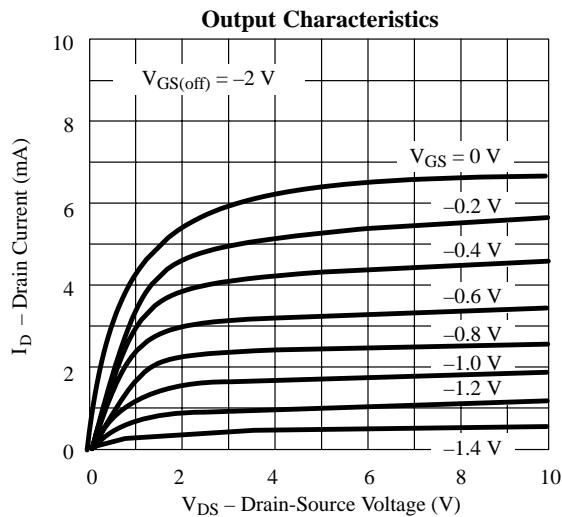
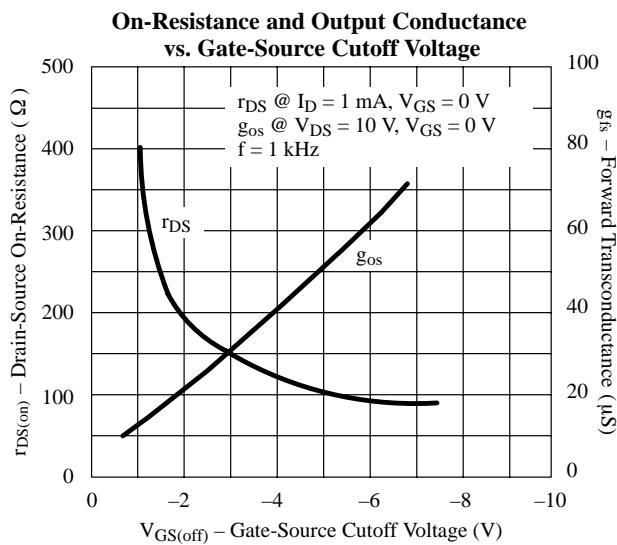
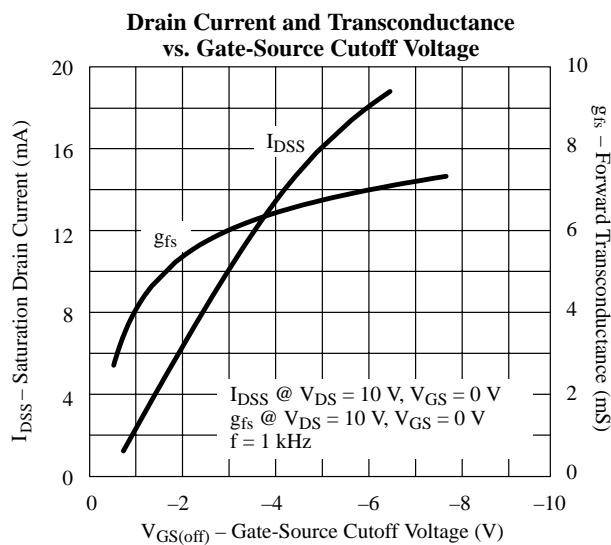
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b. Typical values are for DESIGN AID ONLY, not guaranteed nor subject to production testing.

c. Pulse test: $PW \leq 300 \mu\text{s}$ duty cycle $\leq 3\%$.

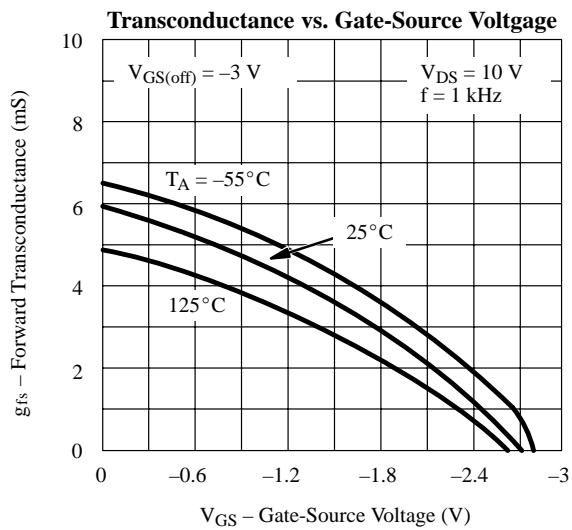
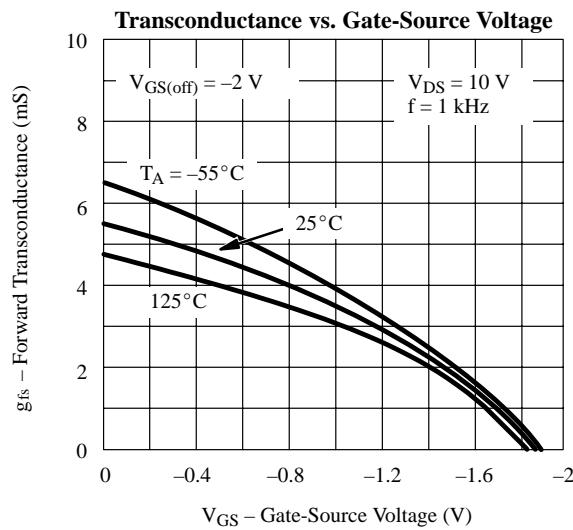
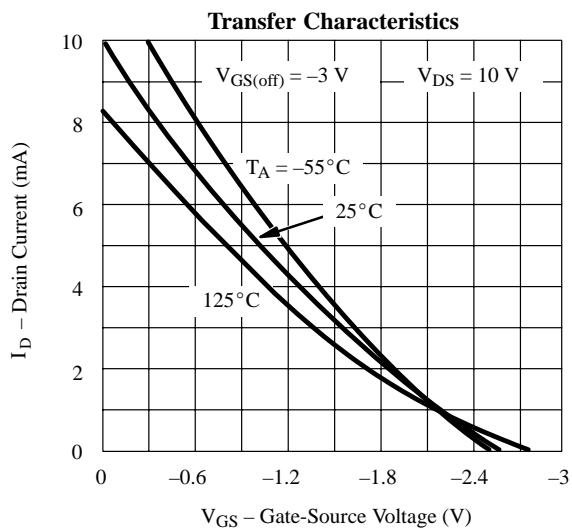
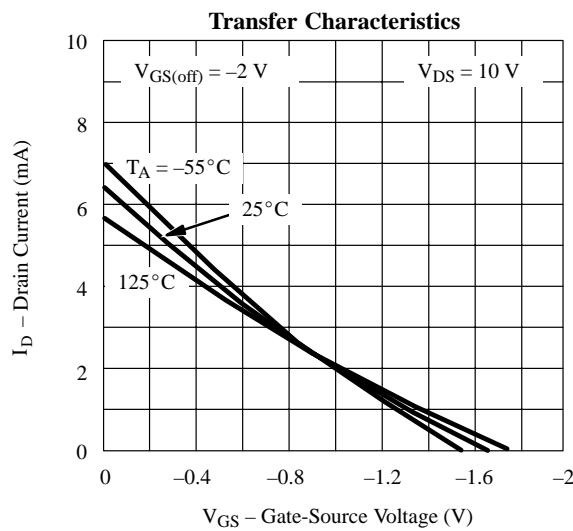
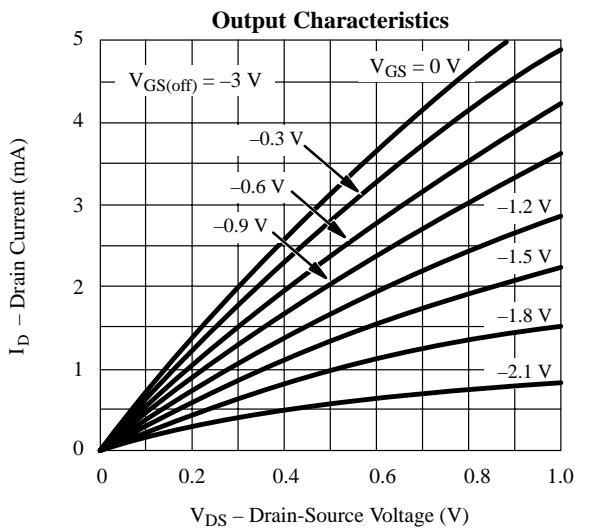
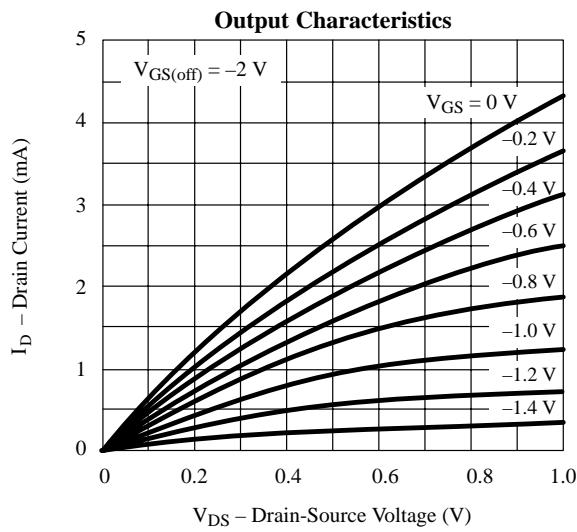
d. This parameter not registered with JEDEC.

Typical Characteristics



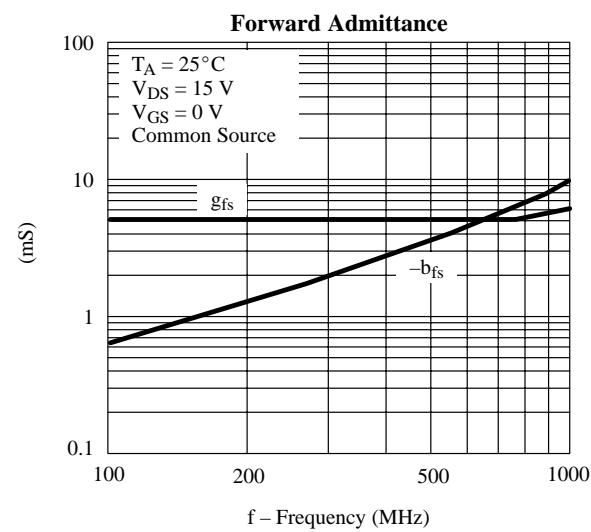
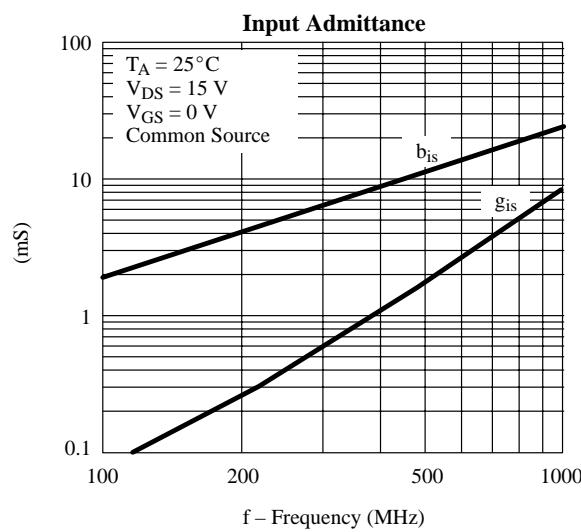
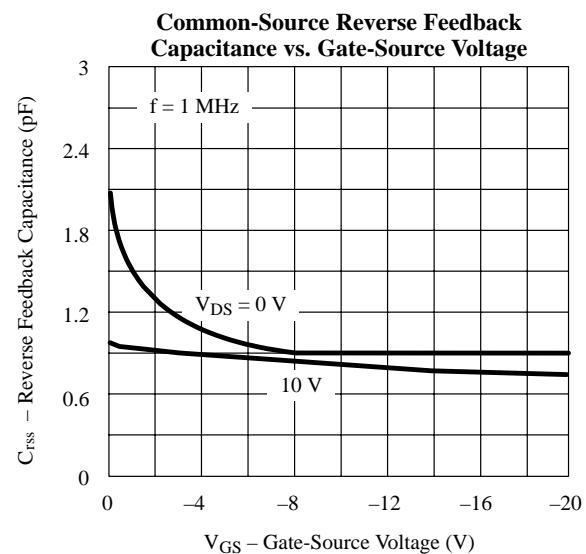
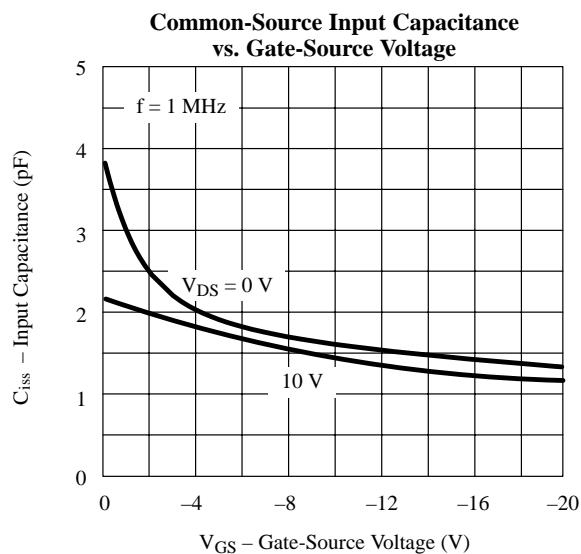
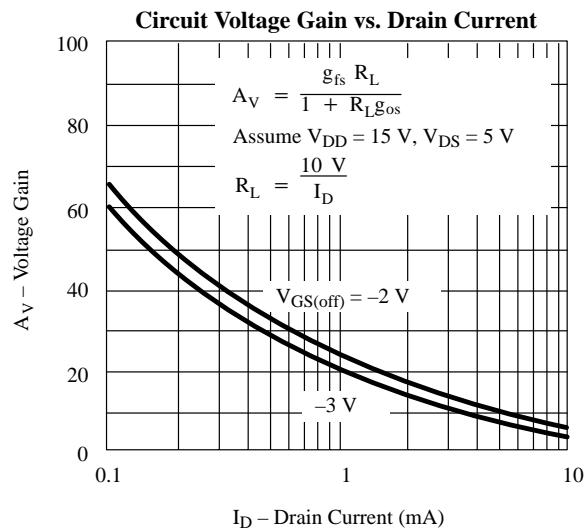
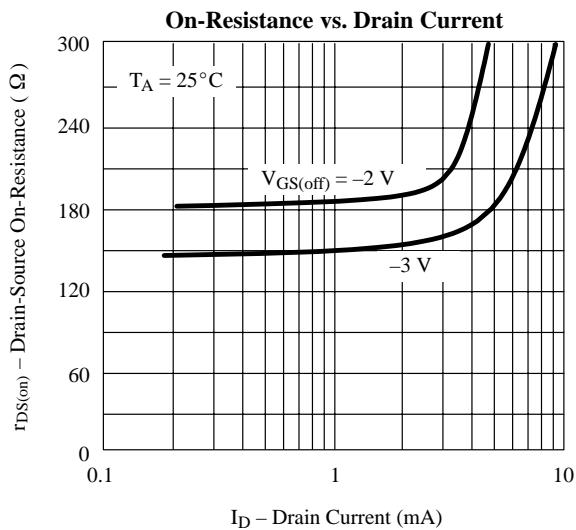
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Typical Characteristics (Cont'd)



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Typical Characteristics (Cont'd)

